

<b>FORM PTO-1449</b> U.S. Department of Commerce Patent and Trademark Office	<b>Docket No.:</b> SCRIP1870-1	<b>Serial No.:</b> 10/560,250
	<b>Applicants:</b> Nemerow et al.	
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>	<b>Filing Date:</b> June 22, 2006	<b>Group Art Unit:</b> 1633

### U.S. PATENT DOCUMENTS

EXAM. INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE

### FOREIGN PATENT DOCUMENTS

EXAM. INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	TRANSLATIO N (YES/NO)
	<b>AA</b>	WO 1995/000655	01-05-1995	Graham et al.			
	<b>AB</b>	WO 1995/034671	12-21-1995	Kovesdi et al.			
	<b>AC</b>	WO 1996/017053	06-06-1996	Hallenbeck et al.			
	<b>AD</b>	WO 1996/022378	07-25-1996	Dedieu et al.			
	<b>AE</b>	WO 1998/013499	04-02-1998	Nemerow et al.			
	<b>AF</b>	WO 1998/054346	12-03-1998	Wickham et al.			
	<b>AG</b>	WO 1999/025860	05-27-1999	Chang et al.			
	<b>AH</b>	WO 1999/039734	08-12-1999	Curiel et al.			
	<b>AI</b>	WO 2000/040558	07-13-2000	Randad et al.			
	<b>AJ</b>	WO 2000/042208	07-20-2000	Nemerow et al.			
	<b>AK</b>	WO 2001/030843	05-03-2001	Barbas et al.			
	<b>AL</b>	WO 2001/083729	08-11-2001	Nemerow et al.			
	<b>AM</b>	WO 2001/092299	06-12-2001	Jakubczak et al.			
	<b>AN</b>	WO 2002/067861	09-06-2002	Ennist et al.			
	<b>AO</b>	WO 2003/062400	07-31-2003	Kaleko et al.			
	<b>AP</b>	WO 2004/099422	11-18-2004	Von Seggern, Daniel, J.			

<b>EXAMINER</b>  GT\6562008.1 312552-31	<b>DATE CONSIDERED</b>
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.